

Notice of References Cited	Application/Control No. 09/787,413	Applicant(s)/Patent Under Reexamination AUWETER ET AL.	
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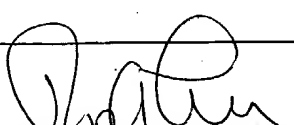
U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,010,150	04-1991	Hennig et al.	526/88
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	L	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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April 12, 2004

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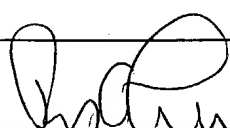
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	A	US-6,494,924 B1	12-2002	Auweter et al.	8/456
	B	US-3,918,688	11-1975	Huber et al.	259/4
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	B	US-5,270,445 A	12-1993	Hou	528/502
	C	US-			
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*	N	WO 99/51695 A1	10-1999	International	Auweter et al.	C09D 11/00
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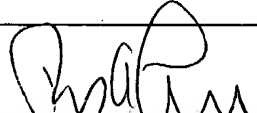
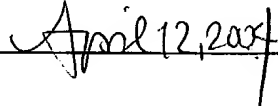
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